

Notice of References Cited	Application/Control No. 10/629,783	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Sikyln Ip	Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0236133	12-2003	Shimazaki et al.	473/345
	C	US-5,089,067	02-1992	Schumacher, William J.	148/325
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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